

**FMX-4206S**

Jan. 2010

Fast Recovery Diode

**General Description**

FRD that has great balance low-VF and high speed performance is incorporated into high-current package TO-3PF.

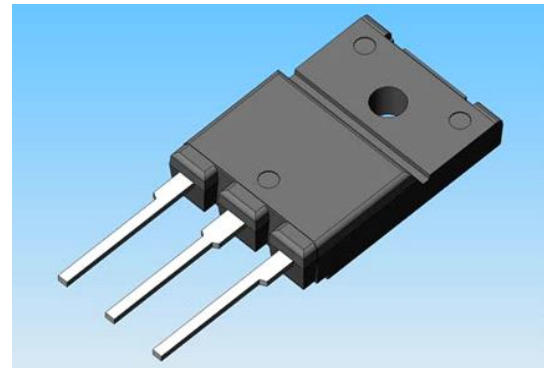
It achieved a balance between high speed at high temperature operates and low-VF.

**Applications**

- DCM or CCM type PFC circuit  
(Power factor improvement circuit)
- DC-DC converters.  
(Forward type/ flyback type/ current resonance type)

**Features**

- An ultrafast recovery diode.
- A balance low-VF and high speed performance at high temperature.
- A great radiation performance due to high-current package.
- A great isolation performance due to full mold package.

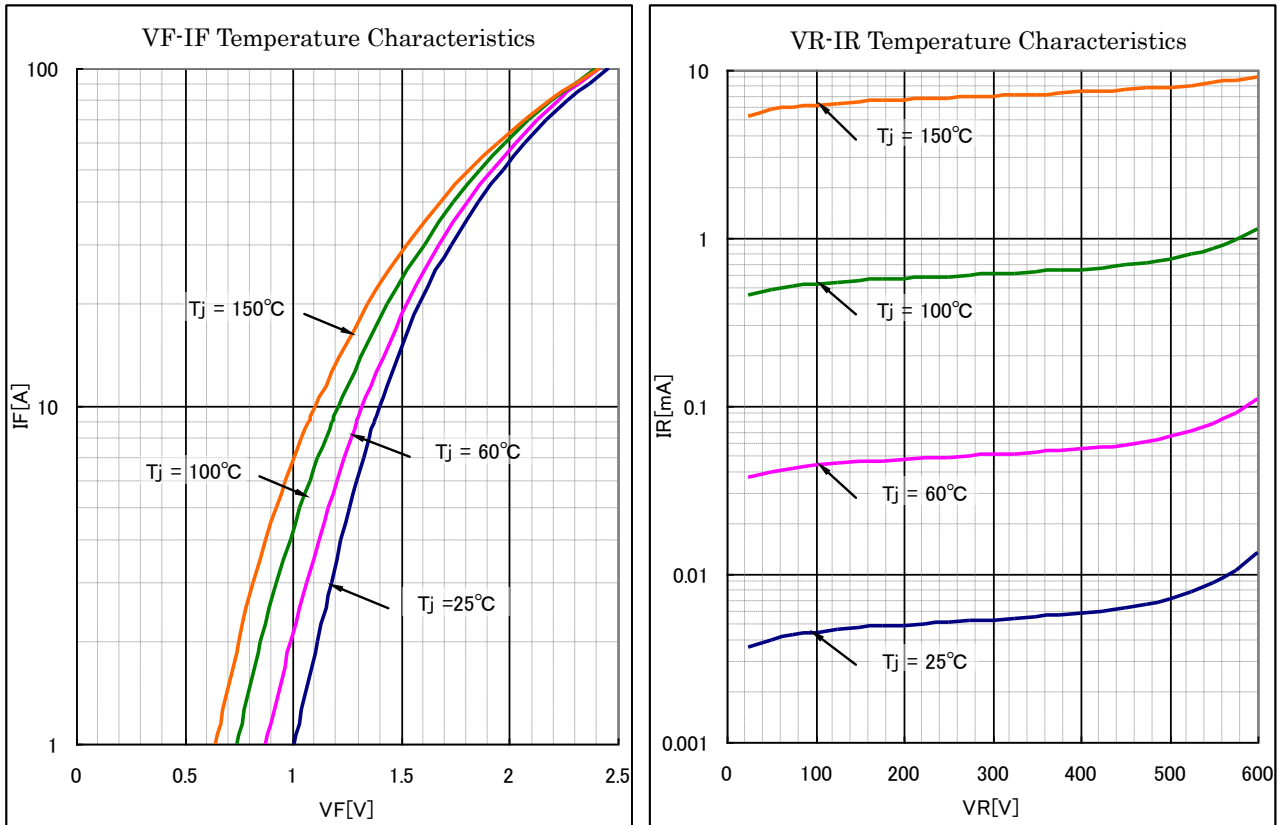
**Package (TO-3PF 3pin)****Key Specifications**

Item	Unit	Rating	Conditions
$V_{RM}$	V	600	
$V_F$	V	1.5	$I_F=10A$
$I_{F(AV)}$	A	20	
$t_{rr1}$	ns	30	
$t_{rr2}$	ns	—	

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Typical Characteristics



VF-IF & VR-IR show characteristics per one chip.

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★ Absolute maximum ratings

No.	Item	Symbol	Unit	Rating	Conditions
1	Transient Peak Reverse Voltage	$V_{RSM}$	V	600	
2	Peak Reverse Voltage	$V_{RM}$	V	600	
3	Average Forward Current	$I_{F(AV)}$	A	20	Refer to Derating (Page4)
4	Peak Surge Forward Current	$I_{FSM}$	A	100	10msec. Half sinewave, one shot
5	$I^2t$ Limiting Value	$I^2t$	A <sup>2</sup> s	50	1msec $\leq$ t $\leq$ 10msec
6	Junction Temperature	$T_j$	°C	-40~+150	
7	Storage Temperature	$T_{stg}$	°C	-40~+150	

No.1,2,4&5 show characteristics per one chip.

★ Electrical characteristics (Ta=25°C, unless otherwise specified)

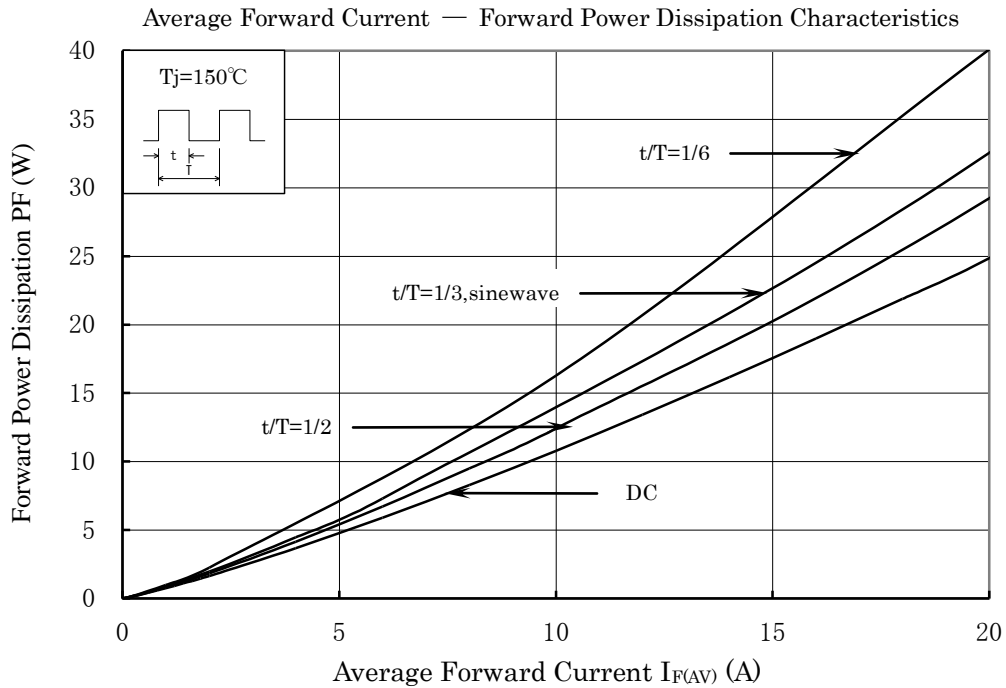
No.	Item	Symbol	Unit	Value	Conditions
1	Forward Voltage Drop	$V_F$	V	1.5 max.	$I_F=10A$
2	Reverse Leakage Current	$I_R$	$\mu A$	100 max.	$V_R=V_{RM}$
3	Reverse Leakage Current Under High Temperature	$H \cdot I_R$	mA	20 max.	$V_R=V_{RM}, T_j=150^\circ C$
4	Reverse Recovery Time	$t_{rr}$	ns	30 max.	$I_F=I_{RP}=500mA$ 90% Recovery point, $T_j=25^\circ C$
		$H \cdot t_{rr}$	ns	102 typ .	$I_F=I_{RP}=500mA$ 90% Recovery point, $T_j=150^\circ C$
5	Forward Voltage Drop	$R_{th(j-c)}$	°C/W	2.0 max.	Between Junction and case

No.1,2,3&4 show characteristics per one chip.

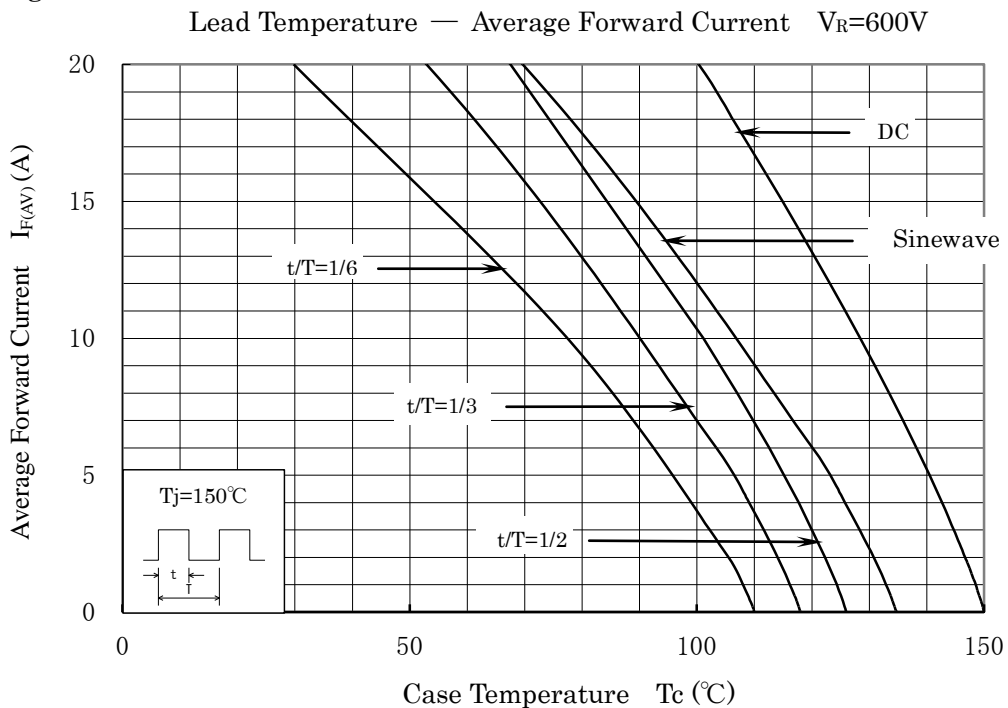
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★ **Characteristics**



★ **Derating**

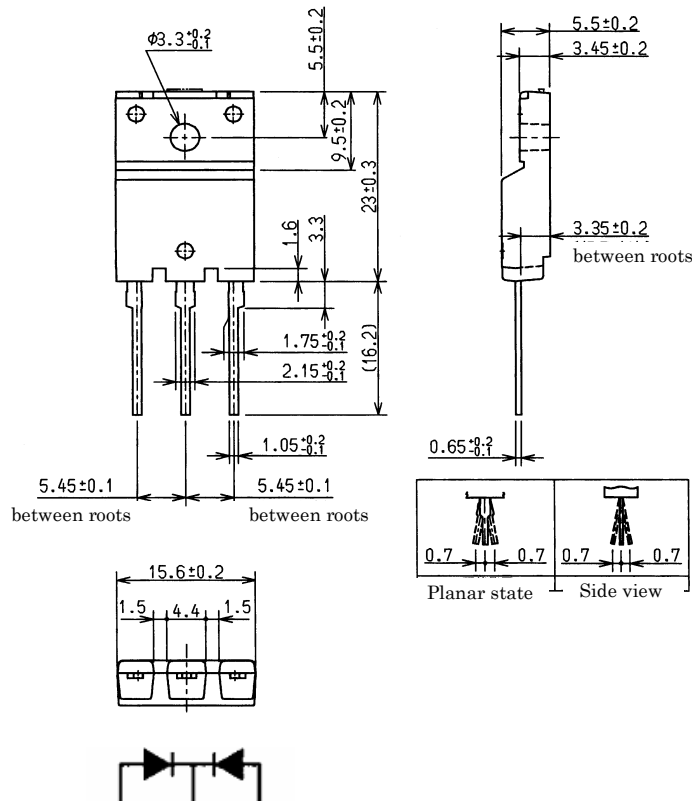


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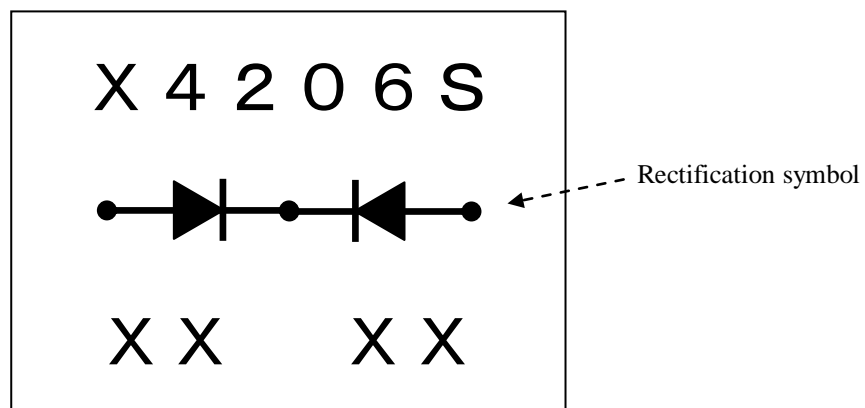
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★ Package information (mm)



★ Marking



X4206S: Part number FMX-4206S is described "X4206S".

XXXX: Lot number (manufacture year, month, day) is described 4-digit numbers.

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